

**Notice of References Cited**Application/Control No.  
10/572,752Applicant(s)/Patent Under  
Reexamination  
NAKAMURA ET AL.Examiner  
JENNIFER F. CHANGArt Unit  
2821

Page 1 of 1

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**NON-PATENT DOCUMENTS**

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\*A copy of this reference is not being furnished with this Office action. (See MPEP § 707.05(a).)  
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